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N-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^{a, g}	Q _g (Typ.)		
20	0.0095 at V _{GS} = 10 V	12	7.3 nC		
	0.0105 at V _{GS} = 4.5 V	10	7.5110		

S

(SOT-23-3L)

Top View

G

FEATURES

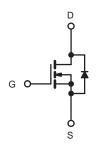
- · DT-Trench Power MOSFET
- 100 % R_q Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



RoHS

APPLICATIONS

- DC/DC Conversion
- POL



N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	± 12	V	
	T _C = 25 °C		12 ^{a, g}		
Continuous Proin Current (T. – 150 °C)	T _C = 70 °C		10 ^g		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	- I _D	11.3 ^{b, c}	^	
	T _A = 70 °C		10.3 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	36 ^g		
Avalanche Current	L = 0.1 mH	I _{AS}	15		
Avalanche Energy	L = 0.111111	E _{AS}	11.25	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C		12 ^{a, g}	A	
	T _A = 25 °C	- I _S	2.9 ^{b, c}		
	T _C = 25 °C		27.7		
Maximum Power Dissipation	T _C = 70 °C	P _D	17.7	w	
	T _A = 25 °C	T D	3.5 ^{b, c}	VV	
	T _A = 70 °C		2.2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	29	36	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	3.6	4.5] 0,,,,	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. The end of the lead terminal is exposed copper
 - (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 81 °C/W.
- g. Package limited.





Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		22		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.0			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	0.5		1.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1		
		V _{DS} = 20 V, V _{GS} = 0 V, T _J = 55 °C			5	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	12			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		0.0095	0.0105	Ω	
		$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$		0.0105	0.0120		
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 10 A		26		S	
Dynamic ^b							
Input Capacitance	C _{iss}			880		pF	
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		310			
Reverse Transfer Capacitance	C _{rss}			125			
Total Gate Charge	Qg	V _{DS} = 10 V, V _{GS} = 10 V, I _D = 10 A		15	23	nC	
				7.3	11		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		2.2			
Gate-Drain Charge	Q _{gd}			2.1			
Gate Resistance	R_g	f = 1 MHz	0.2	0.9	1.8	Ω	
Turn-On Delay Time	t _{d(on)}			15	30	ns	
Rise Time	t _r	V_{DD} = 10 V, R_L = 2 Ω		11	22		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 5$ A, V_{GEN} = 4.5 V, R_g = 1 Ω		16	30		
Fall Time	t _f			8	16		
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	V_{DD} = 10 V, R_L = 2 Ω		8	16		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 5$ A, V_{GEN} = 10 V, R_g = 1 Ω		16	30		
Fall Time	t _f			7	14		
Drain-Source Body Diode Characteristic	cs			•	•		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			12	А	
Pulse Diode Forward Current	I _{SM}				36		
Body Diode Voltage	V_{SD}	I _S = 3 A, V _{GS} = 0 V		0.77	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			14	28	ns	
Body Diode Reverse Recovery Charge	Q_{rr}	I _F = 10 A, dl/dt = 100 A/µs, T _{.I} = 25 °C		4.5	9	nC	
Reverse Recovery Fall Time	t _a	i _F = 10 A, αί/αι = 100 A/μ5, 1 _J = 25 °C		5.5		ns	
Reverse Recovery Rise Time	t _b	_		8.5		ns	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.





I_D - Drain Current (A)

40

32

24

16

8

0.0

0.015

0.013

0.011

0.009

0.007

0.005

 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$ - On-Resistance (Ω)

0.5

1.0

V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics

1.5

 $V_{GS} = 4.5 \text{ V}$

 $V_{GS} = 10 \text{ V}$

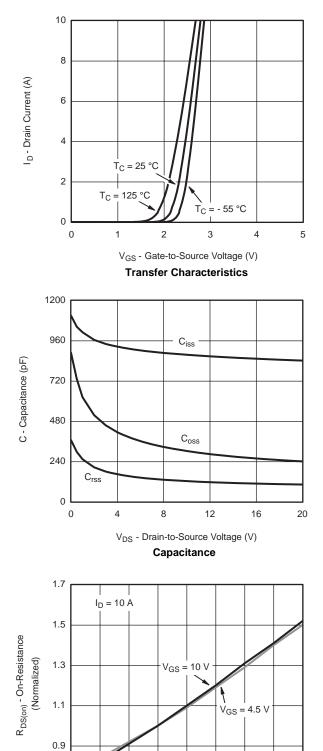
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

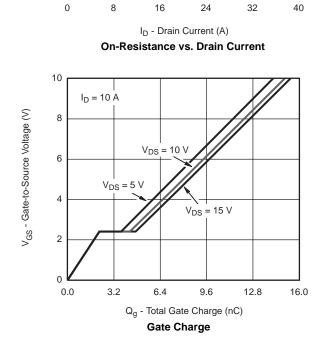
 $V_{GS} = 3 V$

2.0

2.5

 $V_{GS} = 10 \text{ V thru 4 V}$





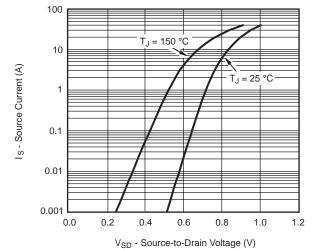
0.7

- 50

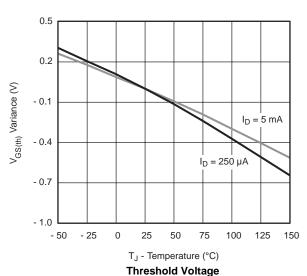




TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

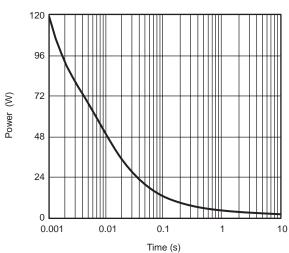


Source-Drain Diode Forward Voltage

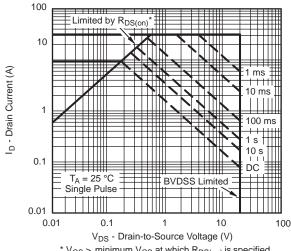


0.05 0.04 $R_{DS(on)}$ - On-Resistance (Ω) 0.03 0.02 T_J = 125 °C 0.01 $T_J = 25$ °C 0.00 0 1 3 4 5

V_{GS} - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power (Junction-to-Ambient)

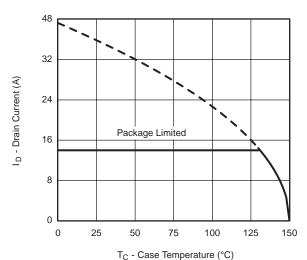


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

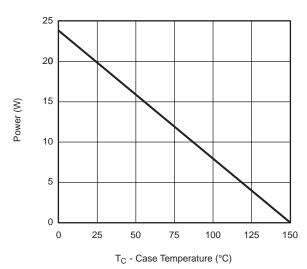
Safe Operating Area, Junction-to-Ambient

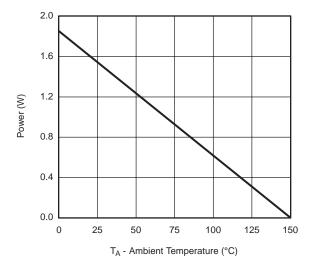


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*





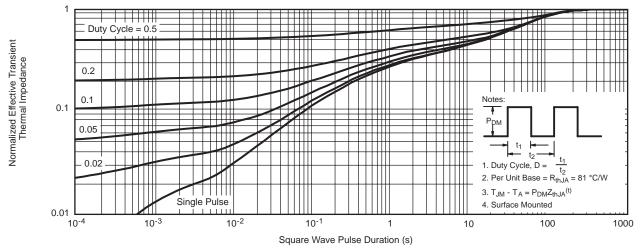
Power, Junction-to-Case

Power, Junction-to-Ambient

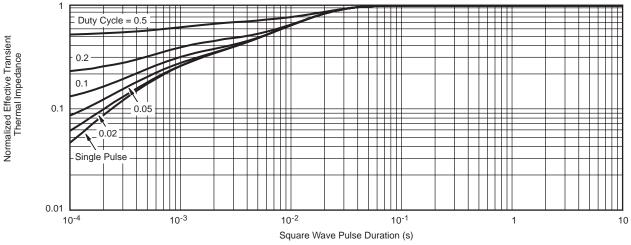
^{*} The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case





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